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FSA831 — USB2.0 High-Speed (480Mbps) Charger Detection with Isolation Switch

Features

USB Detection	USB Battery Charging Rev. 1.2 Supports Data Contact Detect (DCD) Dead Battery Provision (DBP) with 30-Minute Timer
Switch Type	Isolation Switch Closes for Charging Downstream Port (CDP) Standard Downstream Port (SDP)
V _{BUS}	28V Over-Voltage Tolerance -2V Under-Voltage Tolerance
Package	10-Lead MicroPak™ 1.6 x 2.1mm, 0.5mm Pitch
Ordering Information	FSA831L10X

Applications

 MP3, Mobile Internet Device (MID), Cell Phone, PDA, Digital Camera, Notebook and Netbook

Description

The FSA831 is a charger-detection IC with an integrated isolation switch for use with a micro/mini USB port. The FSA831 detects battery chargers and is compliant with USB Battery Charging Specification, Rev 1.2 (BC1.2). The algorithm incorporates Data Contact Detection (DCD), which ensures that the shorter, inner pins of the USB connector are making contact prior to continuing with battery charger detection. The device determines if a Dedicated Charging Port (DCP), Charging Downstream Port (CDP), or a typical PC host, called a Standard Downstream Port (SDP), is connected. If a charger is detected, the FSA831 determines whether the charger is a DCP or CDP. For SDP and CDP detection, an internal isolation switch is closed to connect the D+/D- lines of the USB cable to the resident USB transceiver within the portable device. The FSA831 conforms to all the constraints for the Dead Battery Provision (DBP) within the BC1.2 specification, including a 30-minute timer that cannot exceed 45 minutes, per BC1.2.

Related Resources

 For samples and questions, please contact: <u>analogswitch@fairchildsemi.com</u>.

Typical Application

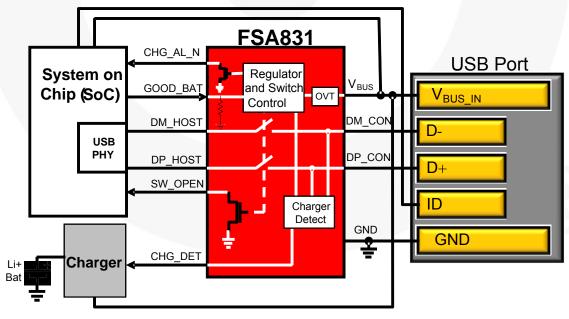


Figure 1. Mobile Phone Example

Pin Configurations

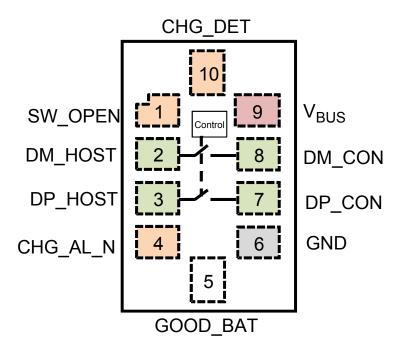


Figure 2. Pin Assignments (Top View)

Pin Descriptions

Name	Pin #	Description				
USB Interface						
DP_HOST	3	D+ signal connected to the resident USB transceiver on the phone				
DM_HOST	2	D- signal connected to the resident USB transceiver on the phone				
Connector Interface						
V _{BUS}	9	Input voltage supply pin to be connected to the V _{BUS} pin of the USB connector				
GND	6	Ground				
DP_CON	7	Connected to the USB connector D+ pin				
DM_CON	8	Connected to the USB connector D- pin				
Status Outputs						
CHG_DET	10	CMOS push/pull output connected to charger IC for indicating if a charger has been detected (LOW=charger not detected, HIGH=DCP or CDP charger has been detected).				
SW_OPEN	1	Open-drain output pin; requires pull-up resistor to I/O voltage supply (LOW=switch closed, Hi-Z=switch open).				
CHG_AL_N 4		CMOS open-drain output pin (LOW= V_{BUS} is valid and charge is allowed to be drawn from V_{BUS} , Hi-Z= V_{BUS} is not at a valid voltage).				
Input Pin						
GOOD_BAT	5	Input that indicates if the battery is a good battery or a dead battery (LOW=dead battery, HIGH=good battery).				

Table 1. Functionality

Device Detected	GOOD_ BAT	SW_ OPEN	CHG_ AL_N	CHG_ DET	DP_HOST	DM_HOST	DP_CON	DM_CON
DCP	Х	Hi-Z	LOW	HIGH	Hi-Z	Hi-Z	V_{DP_SRC}	Hi-Z ⁽¹⁾
CDP	HIGH	LOW	LOW	HIGH	DP_CON	DM_CON	DP_HOST	DM_HOST
CDP	LOW	Hi-Z	LOW	HIGH	Hi-Z	Hi-Z	V _{DP_SRC}	Hi-Z
SDP ⁽²⁾	HIGH	LOW	LOW	LOW	DP_CON	DM_CON	DP_HOST	DM_HOST
SDP ⁽²⁾	LOW	Hi-Z	LOW	LOW	Hi-Z	Hi-Z	V_{DP_SRC}	Hi-Z
SDP, CDP, or DCP plugged in and after 30-minute timer expires	LOW	Hi-Z	Hi-Z	LOW	Hi-Z	Hi-Z	Hi-Z	Hi-Z
V _{BUS} < V _{BUS} valid to V _{BUS} > V _{BUS} valid operation prior to completing detection of SDP, CDP, or DCP. Upon detection, all outputs switch as in rows above.	Х	Hi-Z	Hi-Z	Hi-Z to LOW	Hi-Z	Hi-Z	Hi-Z	Hi-Z

Notes:

- Hi-Z is the internal state of DM_CON. Since a DCP has been detected, DM_CON is shorted to DP_CON externally and DM_CON is shorted to V_{DP_SRC}.
- Proprietary chargers that leave DP_CON and DM_CON floating are detected as SDP. Proprietary chargers that force DP_CON=2V and DM_CON=2.7V (or any other voltages) can be detected as CDP, DCP or SDP depending on the resistances of the resistor dividers on DP_CON and DM_CON used to create the voltages on those pins.

Functional Description

Data Contact Detect (DCD)

DCD relies on the D+ and D- lines being present. DCD waits until the internal timeout (450ms typical) has expired in the following cases:

- If a charger does not have a D+ pin on the USB connector
- If the D+ pin is not shorted to D- pin on the connector,
- If D+ is pulled up to a supply
- If D+ does not have a sufficient path to ground to defeat a pull-up IDP SRC (10µA typical) current source.

The FSA831 proceeds with charger detection even though it is unlikely a charger is present. If there is no charger, the algorithm reports an SDP and closes the switch. If a device is pulling D+ HIGH, this voltage presents itself to the USB transceiver or Physical Layer Interface (PHY) block within a System on Chip (SoC) after the switch is closed

If the DCD timeout was insufficient and the PHY block is so equipped, DCD and the charging algorithm can be repeated in the PHY block. The stipulation is that the total time from V_{BUS} valid to USB transceiver connection with a 1.5k Ω pullup to 3.3V must be one (1) second, per USB 2.0 standards (USB 2.0 connect timing), provided the portable device does not have a dead battery.

A typical PS/2 port (old PC mouse / keyboard port) has a resistive pull-up to V_{BUS} . This can cause the DCD to exceed the maximum wait time ($t_{DCD_TIMEOUT}$) and proceed to charger detection. The likely path through charger detection is classifying the PS/2 port as an SDP port. This results in closing the USB switches, which causes the voltage on the

DP_CON and DM_CON pins to pass through the switch to DP_HOST and DM_HOST, respectively. Since voltages on the PS/2 port can go as high as the V_{BUS} voltage, the DP_HOST and DM_HOST pins can be pulled up to V_{BUS} . The USB PHY connected to DP_HOST and DM_HOST must be equipped to handle these higher voltages.

CHG AL N Output and Output Timing

CHG_AL_N output indicates that charge is allowed to be drawn from V_{BUS} when CHG_AL_N is LOW. When FSA831 first powers up and prior to detection, the CHG_AL_N pin can follow V_{BUS} up to 28V, which is the absolute maximum V_{BUS} voltage allowed. Whenever V_{BUS} is at GND, the FSA831 is completely off and the switches and all I/Os are in the Hi-Z state. When V_{BUS} climbs above the valid V_{BUS} threshold, detection occurs automatically and CHG_DET, SW_OPEN, and CHG_AL_N all simultaneously switch to the states indicated in Table 1 if GOOD_BAT is HIGH (see Dead Battery Provision description for GOOD_BAT = LOW).

Dead Battery Provision

BC1.2 and USB 2.0 allow a portable device (defined as a device with a battery) with a dead battery to take a maximum of 100mA from the USB V_{BUS} line for a maximum of 45 minutes as long as the portable device forces the D+ line to $V_{\text{DP_SRC}}$ (0.6V typical). FSA831 starts detection when V_{BUS} crosses the V_{BUSVLD} threshold and, if it detects a CDP or SDP and GOOD_BAT is HIGH, automatically closes the switch and does not force the DP CON pin to $V_{\text{DP_SRC}}$.

Once the charger detection is completed, the FSA831 starts a 30-minute timer and forces the DP_CON pin to $V_{\text{DP_SRC}}$ until the timer elapses. During the 30 minute period, if

GOOD_BAT is LOW, VDP_SRC is applied to DP_CON and the D+/D- switches are opened, If GOOD_BAT is HIGH, $V_{\text{DP_SRC}}$ is not applied to DP_CON and the D+/D- switches are closed, If GOOD_BAT is LOW when 30 minute timer expires; regardless of whether an SDP, CDP, or DCP was previously detected; the FSA831 removes $V_{\text{DP_SRC}}$ from DP_CON and forces CHG_DET LOW and CHG_AL_N to Hi-Z (SW_OPEN remains Hi-Z) To exit this fault condition, remove V_{BUS} , wait for all the V_{BUS} Printed Circuit Board (PCB) capacitance to discharge, and re-apply V_{BUS} . Table 1 provides the functionality of the pins when the timer expires.

When GOOD_BAT is HIGH and the battery is removed from the portable device while V_{BUS} is valid, bringing GOOD_BAT LOW; the FSA831 opens the isolation switches on DP_CON and DM_CON and forces the DP_CON pin to V_{DP_SRC} . In this scenario, the timer generally expires because the SoC does not have a supply to bring GOOD_BAT HIGH unless the battery that was removed is re-inserted within 30 minutes from when the USB plug is inserted.

If an SDP or CDP is inserted with GOOD_BAT HIGH during the 30-minute timer, then GOOD_BAT changes to LOW; SW_OPEN changes to Hi-Z and the counter continues counting until the 30 minutes expires. If GOOD_BAT then returns to HIGH, SW_OPEN changes to LOW and finishes out the 30-minute time.

GOOD_BAT has an internal pull-down resistor to ensure it is LOW when the SoC is powered down. This input is designed to have very low thresholds to interface with low-voltage SoCs driven with 1.2V supplies.

Proprietary Chargers

Only legitimate USB chargers that force VDM_SRC (0.6V typical) on DM_CON when VDP_SRC is applied to DP_CON are detected by the FSA831 and cause CHG_DET signal to be asserted. Any charger that forces a HIGH on both DP_CON and DM_CON can be detected as CDP, DCP, or

SDP (depending on the resistances of the resistor dividers on DP_CON and DM_CON) and used to create the HIGH voltages on those pins. Any charger that lets both DP_CON and DM_CON signals float is detected as an SDP and CHG_DET stays de-asserted. In cases where the proprietary charger is detected as an SDP or CDP, since the switches are closed and access is made from the USB connector D+ and D- lines to the USB PHY block; the chargers can be detected within the PHY if so equipped

Ground Drops

When a DCP is detected, V_{DP_SRC} is forced on DP_CON provided GOOD_BAT is HIGH or if GOOD_BAT is LOW and the DBP timer has not expired. For current up to 1.5A flowing into the V_{BUS} and GND lines of the USB cable, this can translate to substantial ground drops that lift the ground of the portable device. This drop adds to the voltage at the DP_CON pin as seen from the DCP D+ pin. For the maximum ground drop of 375mV specified in the BC1.2 specification and for the maximum V_{DP_SRC} of 0.7V, the voltage as seen by the DCP would be 1.075V. Smart DCPs that rely on this voltage detection to determine attach and detach detection need to take this into account.

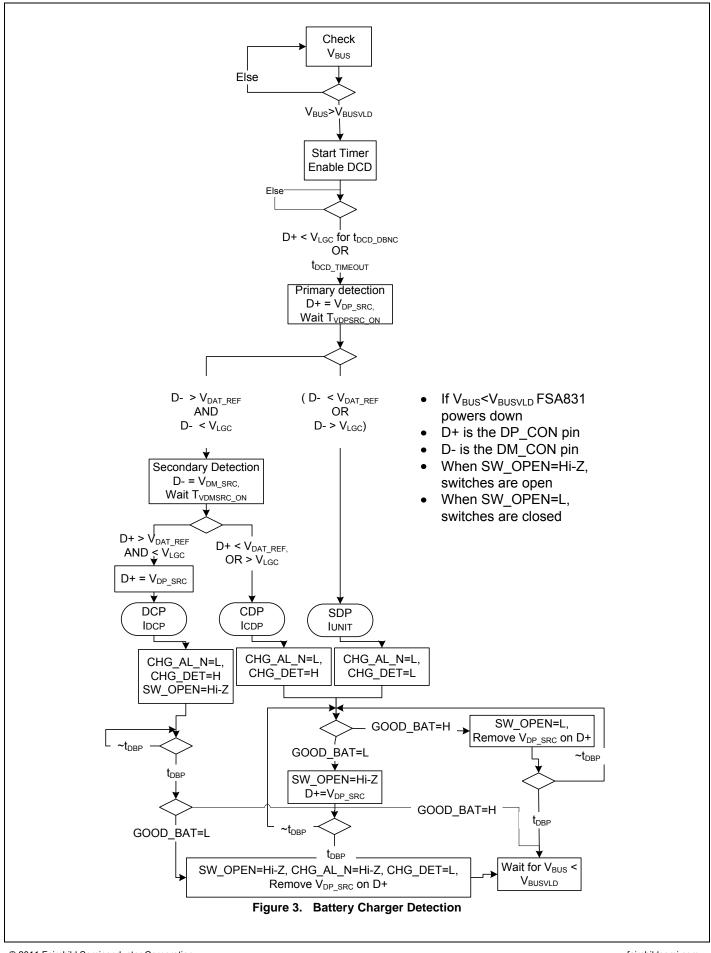
V_{BUS} Tolerance

When V_{BUS} rises, an internal Power On Reset (POR) detects this voltage and prepares the FSA831 for charger detection.

 V_{BUS} voltages up to 28V can be tolerated by the V_{BUS} pin. V_{BUS} can tolerate voltages up to -2V for cases where a charger is plugged in backwards.

Detection Flow

The flow diagram in Figure 3 shows how the FSA831 achieves battery charger detection consistent with BC1.2.



Absolute Maximum Ratings

Stresses exceeding the absolute maximum ratings may damage the device. The device may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only.

Symbol		Parameter					
V _{BUS}	Voltage from USB Conne	ector		-2	28	V	
V _{SW}	USB Switch I/O Voltage (DP_CON, DM_CON, DP_HOST, DM_H	OST)	-0.5	6.0	V	
I _{SW}	USB Switch Current (DP	_CON to DP_HOST, DM_CON to DM_H	OST)	-30	+30	mA	
V _{I/O}	Voltage from GOOD_BA	T, CHG_AL_N, CHG_DET and SW_OPE	N I/Os	-0.5	6.0	V	
V _{CA}	Voltage from CHG_AL_N	Voltage from CHG_AL_N Output				V	
I _{I/O}	CHG_AL_N, CHG_DET and SW_OPEN Outputs Sink/Source Current				+5	mA	
T _{STG}	Storage Temperature Ra		-65	+150	°C		
TJ	Maximum Junction Temp	erature			+150	°C	
T _L	Lead Temperature (Solde	ering, 10 Seconds)			+260	°C	
	IEC 64000 4 2 Cyatam	LICE Diag (DD, CON, DM, CON, V,	Air Gap		15		
ECD	IEC 61000-4-2 System	USB Pins (DP_CON, DM_CON, V _{BUS})	Contact		8	147	
ESD	Human Body Model, JEDEC JESD22-A114 All Pins				6	kV	
	Charged Device Model, c	IEDEC JESD22-C101	All Pins		2		

Recommended Operating Conditions

The Recommended Operating Conditions table defines the conditions for actual device operation. Recommended operating conditions are specified to ensure optimal performance to the datasheet specifications. Fairchild does not recommend exceeding them or designing to Absolute Maximum Ratings.

Symbol	Parameter		Max.	Unit
V_{BUS}	V _{BUS} Input HIGH Voltage		6	V
V_{SW}	Switch I/O Voltage for USB Path		3.6	V
T _A	Operating Temperature	-40	+85	°C

DC Electrical Characteristics

Unless otherwise indicated, V_{BUS}=4V to 6V and T_A=-40 to +85°C. Typical values are at T_A=25°C unless otherwise specified.

Symbol	Parameter Condition		Min.	Тур.	Max.	Unit
Status Out	tputs					
V_{OHCD}	Output HIGH Voltage (CHG_DET)	I _{OH} =-2mA	2.0			V
V_{OL}	Output LOW Voltage (CHG_DET, CHG_AL_N, SW_OPEN)	I _{OL} =2mA			0.4	V
t _{DIFF}	Skew Between Any Output (CHG_DET, CHG_AL_N, SW_OPEN) Switching Relative to the Other Outputs Switching	$I_{I/O}$ =±2mA, CHG_AL_N=20kΩ to 5V, SW_OPEN=10kΩ to 1.8V			100	ns
V _{BUS} Pin			•	•		,
VBUS _{VLD}	V _{BUS} Valid Detection Threshold ⁽¹⁾		0.8		4.0	V
I _{BUSIN}	V _{BUS} Input Leakage	V _{BUS} =0V to 0.8V			10	μA
I _{VBUSACT}	V _{BUS} Active Mode Average Current	USB Path Active, USB Switch Closed After Charger Detection			400	μΑ
t _{out}	Time from V _{BUS} Valid Asserted to CHG_DET, CHG_AL_N and SW_OPEN Outputs Valid	DP_CON pulled down to GND, $15k\Omega$, all voltages forced on V_{BUS} , DP_CON, DM_CON and GND simultaneously			250	ms
Switch Ch	aracteristics					•
I _{OFF}	Power Off Leakage Current	USB Path V _{BUS} =0V, V _{SW} =0V or 3.6V, Figure 5			10	μA
Ronusb	High-Speed USB Range Switch On Resistance ⁽¹⁾ $V_{DP_CON} / V_{DM_CON} = 0V, 0.4V;$ $I_{ON} = 8mA; Figure 4; V_{BUS} = 4V to 6V$			6.5	9.0	Ω
Control In	put					
V _{IH}	Input HIGH Voltage (GOOD_BAT)		1.1			V
V _{IL}	Input LOW Voltage (GOOD_BAT)				0.5	V
R_{PD}	Pull Down Resistance (GOOD_BAT)		1			МΩ
I _{IN}	Input Leakage Current (GOOD_BAT)	V _{BUS} =5V, GOOD_BAT=0V to 4.4V			10	μA
I _{IOFF}	OFF State Leakage Current (GOOD_BAT)	V _{BUS} =0V, GOOD_BAT=0V to 4.4V			10	μΑ
t _{DBP}	Dead Battery Provision (DBP) Timer		15	30	45	min
$t_{\sf GB}$	Time from GOOD_BAT Asserted to SW_OPEN Meet the R _{ONUSB} Specification	N De-Asserted, Switches Closed and			30	ms
t _{DB}	Time from GOOD_BAT De-asserted to SW_O	PEN Asserted, Switches Opened			65	ms
Battery Ch	narger Detection Parameters from BC1.2 Spe	cification				•
V _{DAT_REF}	Data Detect Voltage		0.25		0.40	V
V_{DM_SRC}	D- Source Voltage ⁽²⁾		0.5		0.7	V
V _{DP_SRC}	D+ Source Voltage ⁽²⁾		0.5		0.7	V
V_{LGC}	Logic Threshold		0.8		2.0	V
I _{DM_SINK}	D- Sink Current		25		175	μA
I _{DP_SINK}	D+ Sink Current	25		175	μA	
I _{DP_SRC}	Data Contact Detect Current Source	7		13	μΑ	
t _{DCD_DBNC}	Data Contact Detect Debounce		10			ms
t _{DCD_TOUT}	Time for DCD to Timeout		300	450	900	ms
t _{VDPSRC_ON}	D+ Voltage Source On Time		40			ms
t	D- Voltage Source On Time		40			ms

Notes:

- 1. Guaranteed by characterization; not production tested.
- The voltage source, V_{DP_SRC} / V_{DM_SRC}, is able to source at least 250µA when the output voltage is in the specified range.
 This voltage source should not pull DP_CON / DM_CON below 2.2V when DP_CON / DM_CON is pulled to a voltage of 3.0V minimum or 3.6V maximum with a resistance of 900Ω minimum or 1575Ω maximum.

AC Electrical Characteristics

Unless otherwise specified, values are at T_A =-40 to +85°C; all typical values are for V_{CC} =3.3V at T_A =25°C.

Symbol	Parameter	Condition	Min.	Тур.	Max.	Unit	Figure
Xtalk	Trouve charmer discoulant, Bi _colv to	f=1MHz, R_T =50 Ω , C_L =0pF		-78		dB	Figure 7
Aldik	DM_CON ⁽³⁾	f=240MHz, R_T =50 Ω , C_L =0pF		-36		uБ	Figure 7
		f=1MHz, R _T =50Ω, C _L =0pF		-84		dB	Ciguro 6
O _{IRR}	DM_HOST to DM_CON, DP_HOST to DP_CON ⁽³⁾	f=240MHz, R_T =50 Ω , C_L =0pF		-34		uБ	Figure 6

Note:

3. Guaranteed by characterization; not production tested.

Capacitance

Unless otherwise specified, values are at T_A =-40 to +85°C.

Symbol	Parameter	Condition	Typical	Unit	Figure
C _{OFF}	DP_CON, DM_CON Off Capacitance ⁽⁴⁾	V _{BIAS} =0.2V, f=1MHz	3.9	pF	Figure 8
C _{ON}	DP_CON, DM_CON On Capacitance ⁽⁴⁾	V _{BIAS} =0.2V, f=1MHz	7.2	pF	Figure 9

Note:

4. Guaranteed by characterization; not production tested.

Test Diagrams

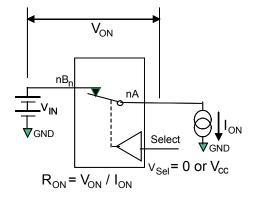
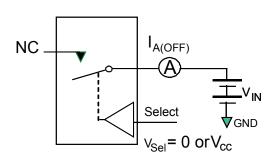
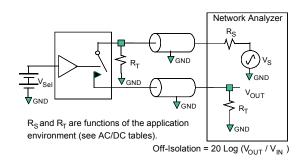


Figure 4. On Resistance



**Each switch port is tested separately.

Figure 5. Off Leakage



Network Analyzer R_S $V_{S1, S2, S3}$ $V_{S1, S2, S3}$

Figure 6. Channel Off Isolation

Figure 7. Active Channel Crosstalk

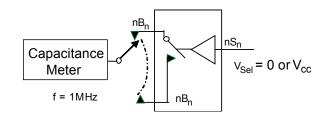


Figure 8. Channel Off Capacitance

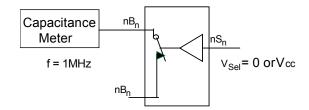


Figure 9. Channel On Capacitance

Physical Dimensions

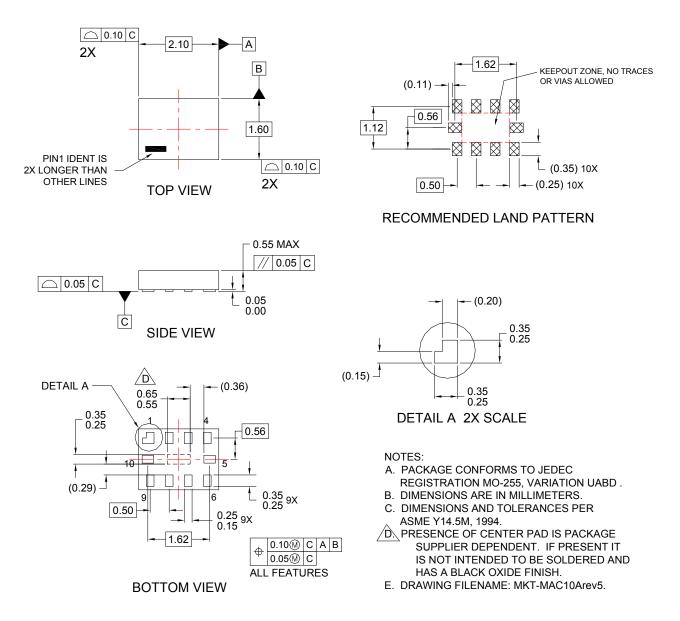


Figure 10. 10-Lead, MicroPak™

Part Number	Top Mark	Operating Temperature Range	Package Description	Packing Method
FSA831L10X	KY	-411 to 85°1	10-Lead, MicroPak™ 1.6 x 2.1mm, 0.5mm Pitch	Tape & Reel

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Rev. 159

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